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ELECTRODEPOSITED Ni-W MAGNETIC THIN FILMS WITH COLUMNAR NANOCRYSTALLITES

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Nanocrystalline Ni-W thin films (140 nm) containing from zero to 18 wt % W were electrochemically prepared and structural and magnetic characterized. XRD, SEM and TEM investigations have revealed that all segregated Ni columns are fcc-type whose [111] axis is oriented perpendicular to the film plane and have 140 nm in height and 6-27 nm in diameter. Depending on film composition, two types of nanostructures were observed: (a) single-phase nanostructure (< 7 wt % W) which consist of nanocrystalline Ni columns ($d = 14-27$ nm) separated by interfaces or "interphases", namely W enriched particles boundaries, and (b) two-phase nanostructure (7-18 wt %) in which a second Ni-W amorphous phase or even amorphous-disordered mixture separates the magnetic columnar Ni nanocrystallites ($d = 6-14$ nm). The $\langle 111 \rangle$ columnar crystallites have an easy magnetization direction along their long axis mainly due to the in-plane internal biaxial stresses. The saturation magnetization non-linearly decreased with small grain size. The variation of in-plane coercivity H_c of these phase-separated thin films is typical of single-domain Ni grains and reaches a maximum for 13 wt % W in composition. The magnetic properties strongly depend on crystallite size and its isolation degree, and their variation is characteristic for a single-domain magnetic particles. Our investigation finds out that average crystallite size and its isolation degree can be controlled, and the magnetic properties optimized, by choosing appropriate Ni-W composition. For example, typical Ni-W films, 13 wt % W in composition, behave as a system of perpendicular Ni columns 12.5 nm in diameter embedded in an amorphous Ni-W matrix with high perpendicular magnetic anisotropy, and each crystallite would correspond to one information bit. These kind of samples exhibit semi-hard magnetic characteristics: saturation magnetization $M_s = 419$ kA/m, in-plane coercivity $H_{c//} = 49$ kA/m, $H_{c\perp} = 118$ kA/m, quite high squareness ratio $S = 0.6$ and very high coercivity squareness $S^* = 0.83$. These magnetic characteristics are in well agreement with the required parameters for a high density magnetic recording medium.

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